

**Search Notes**

Application/Control No.

10/754,488

Examiner

Bruck Kifle, Ph.D.

Applicant(s)/Patent under  
Reexamination

NAICKER ET AL.

Art Unit

1624

**SEARCHED**

Class	Subclass	Date	Examiner
514	291	4/22/2005	BK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
514	291	4/22/2005	BK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR